



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Jun Koyama et al.

Art Unit : 2871

Serial No.: 10/620,565

Examiner: Unknown

Filed

: July 17, 2003

Title

: SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

MAIL STOP AMENDMENTS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT AND NOTICE OF RELATED APPLICATIONS

Supplemental to an information disclosure statement filed November 22, 2004, Applicants submit full translations of Japan Patent Nos. JP04-313729, JP05-053127, JP05-241200, JP06-160904, and JP07-175038. The translations of each of these references are enclosed.

Applicants also wish to bring to the Examiner's attention related application Serial Nos. 10/803,965, filed March 19, 2004, 10/850,117, filed May 21, 2004, and 10/960,897, filed October 8, 2004.

This statement is being filed before the receipt of a first Office Action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: January 5, 2005

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Substitute (Modifier)

m PTO-1449

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 07977-209003

Application No. 10/620,565

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Jun Koyama et al.

Applicant

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(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	10/803,965	Pending	KOYAMA et al.			03/19/2004
	AB	10/850,117	Pending	KOYAMA et al.			05/21/2004
	AC	10/960,897	Pending	KOYAMA et al.			10/08/2004
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Translation	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	JP04-313729	05 NOV 1992	JAPAN			Full	
	AM	JP05-053127	05 MAR 1993	JAPAN			Full	
	AN	JP05-241200	21 SEPT 1993	JAPAN			Full	
	AO	ЈР06-160904	07 JUNE 1994	JAPAN			Full	
	AP	JP07-175038	14 JULY 1995	JAPAN			Full	

Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.				
Initial	ID	Document			
_	AQ				
	AR				
	AS				
	AT				

Examiner Signature	Date Considered				
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with					
next communication to applicant.					